

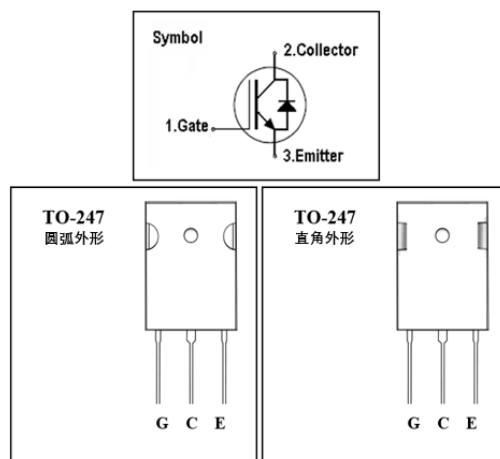
## IGBT

### Features

- 1200V,15A
- $V_{CE(sat)}(typ.)=1.95V @ V_{GE}=15V, I_C=15A$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA

### General Description

JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as IH (induction heating), UPS, general inverter and other soft switching applications.



### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
$V_{CES}$	Collector-Emitter Voltage	1200	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 30$	V
$I_C$	Continuous Collector Current ( $T_C=25^\circ C$ )	30	A
	Continuous Collector Current ( $T_C=100^\circ C$ )	15	A
$I_{CM}$	Pulsed Collector Current (Note 1)	45	A
$I_F$	Diode Continuous Forward Current ( $T_C=100^\circ C$ )	15	A
$I_{FM}$	Diode Maximum Forward Current (Note 1)	45	A
$t_{sc}$	Short Circuit Withstand Time	10	us
$P_D$	Maximum Power Dissipation ( $T_C=25^\circ C$ )	108	W
	Maximum Power Dissipation ( $T_C=100^\circ C$ )	43	W
$T_J$	Operating Junction Temperature Range	-40 to +155	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to +155	$^\circ C$

### Thermal Characteristics

Symbol	Parameter	Max.	Units
$R_{th j-c}$	Thermal Resistance, Junction to case for IGBT	1.15	$^\circ C / W$
$R_{th j-c}$	Thermal Resistance, Junction to case for Diode	1.5	$^\circ C / W$
$R_{th j-a}$	Thermal Resistance, Junction to Ambient	40	$^\circ C / W$

**Electrical Characteristics** ( $T_C=25^{\circ}\text{C}$  unless otherwise noted )

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$BV_{CES}$	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_C=250\mu A$	1200	-	-	V
$I_{CES}$	Collector-Emitter Leakage Current	$V_{CE}=1200V, V_{GE}=0V$	-	-	100	$\mu A$
$I_{GES}$	Gate Leakage Current, Forward	$V_{GE}=30V, V_{CE}=0V$	-	-	100	nA
	Gate Leakage Current, Reverse	$V_{GE}=-30V, V_{CE}=0V$	-	-	100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE}=V_{CE}, I_C=250\mu A$	4.5	-	6.5	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=15V, I_C=15A$	-	1.95	2.4	V
$Q_g$	Total Gate Charge	$V_{CC}=600V$ $V_{GE}=15V$ $I_C=15A$	-	120		nC
$Q_{ge}$	Gate-Emitter Charge		-	50		nC
$Q_{gc}$	Gate-Collector Charge		-	15		nC
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=600V$ $V_{GE}=15V$ $I_C=15A$ $R_G=15\Omega$ Inductive Load $T_C=25^{\circ}\text{C}$	-	37	-	ns
$t_r$	Turn-on Rise Time		-	74	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	83	-	ns
$t_f$	Turn-off Fall Time		-	93	-	ns
$E_{on}$	Turn-on Switching Loss		-	1.24	-	mJ
$E_{off}$	Turn-off Switching Loss		-	0.48	-	mJ
$E_{ts}$	Total Switching Loss		-	1.72	-	mJ
$C_{ies}$	Input Capacitance	$V_{CE}=25V$	-	2460	-	pF
$C_{oes}$	Output Capacitance	$V_{GE}=0V$	-	95	-	pF
$C_{res}$	Reverse Transfer Capacitance	$f=1\text{MHz}$	-	45	-	pF

**Electrical Characteristics of Diode** ( $T_C=25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_F$	Diode Forward Voltage	$I_F=15A$	-	2.1	3.5	V
$t_{rr}$	Diode Reverse Recovery Time	$V_{CE}=600V$	-	62		ns
$I_{rr}$	Diode peak Reverse Recovery Current	$I_F=15A$	-	15		A
$Q_{rr}$	Diode Reverse Recovery Charge	$R_G=15\Omega$	-	470		nC

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature

## Typical Performance Characteristics

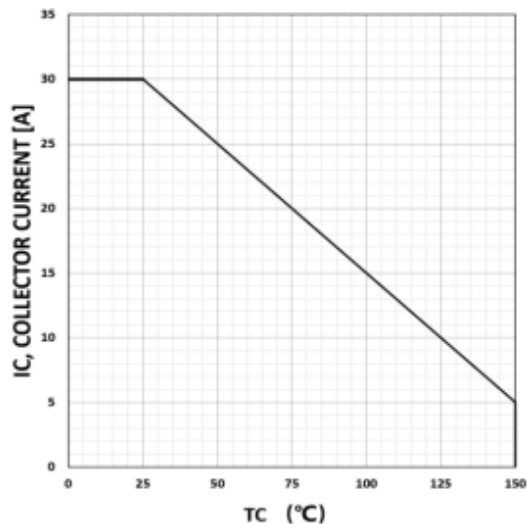


Figure 1. Maximum DC collector current  
VS. case temperature

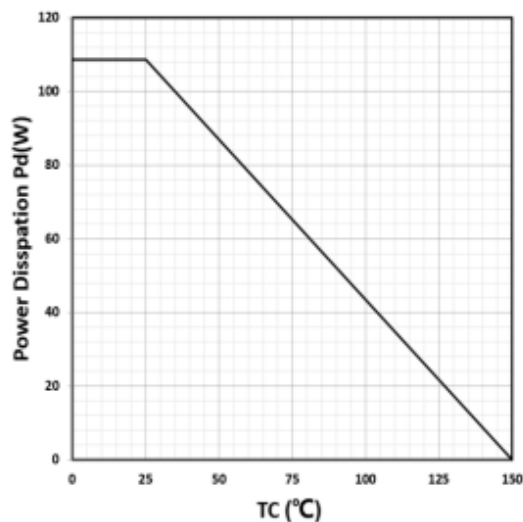


Figure 2. Power dissipation VS. case temperature

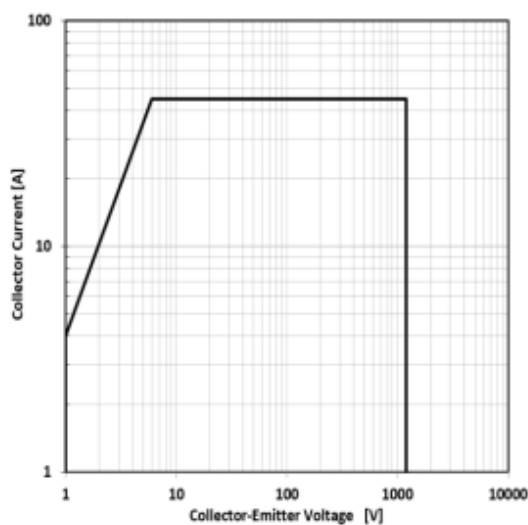


Figure 3. Reverse bias SOA,  $T_J=125^{\circ}\text{C}$ ,  $V_{GE}=15\text{V}$

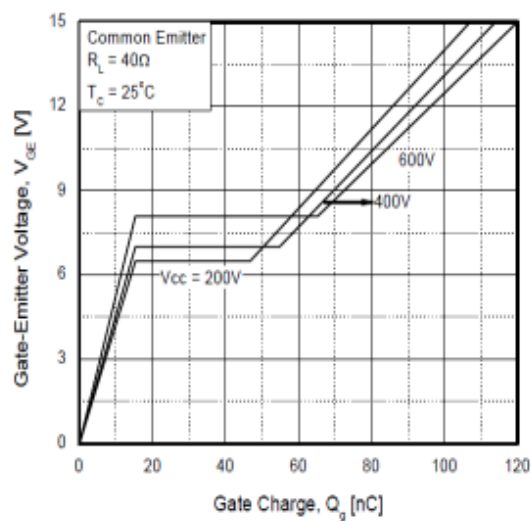


Figure 4: Typical gate charge VS.  $V_{GE}$ ,  $I_C=15\text{A}$

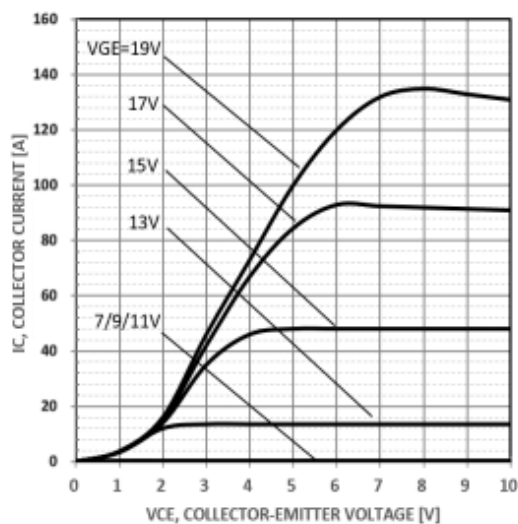


Figure 5. Typical output characteristics  
 $t_p=300\mu s$   $T_c=25^\circ C$

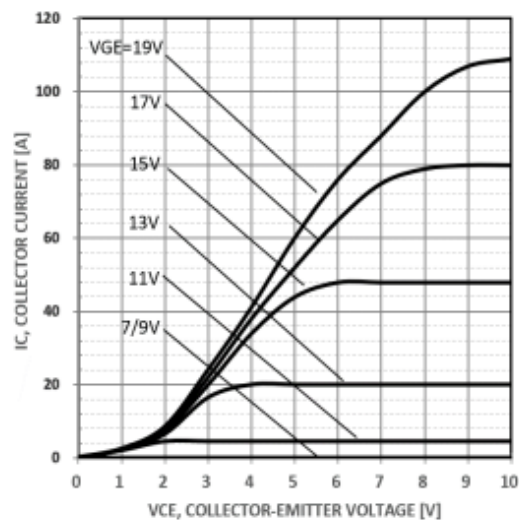


Figure 6. Typical output characteristics  
 $t_p=300\mu s$   $T_c=150^\circ C$

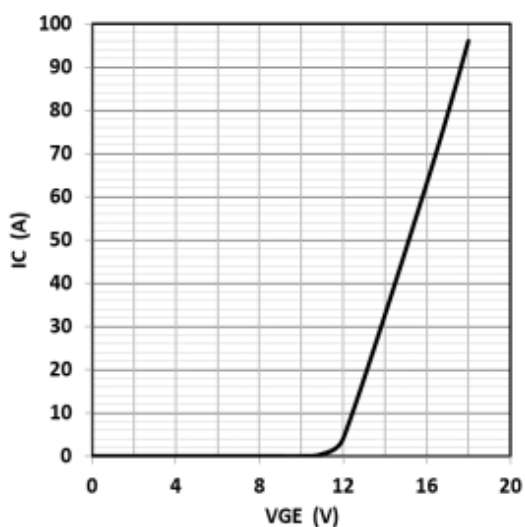


Figure 7. Typical gate threshold voltage

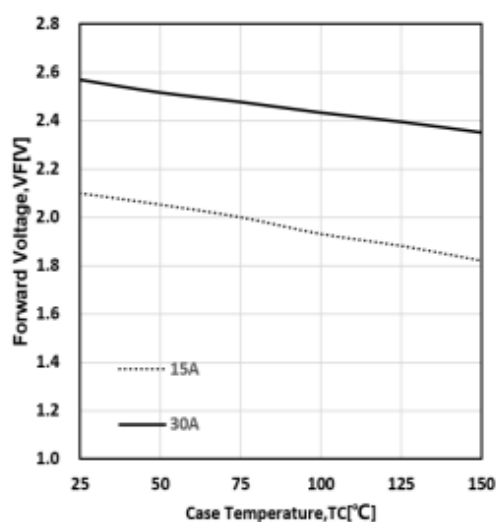


Figure 8. Typical forward voltage vs  $T_c$

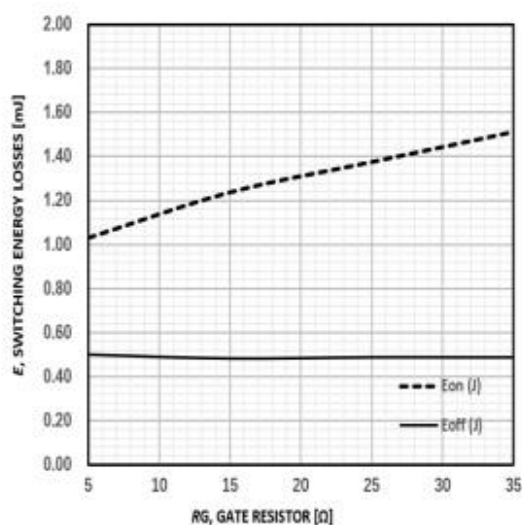


Figure9: Typical energy loss VS.  $R_g$ ,  $T_C=25^{\circ}\text{C}$ ,  
 $V_{CE}=600\text{V}$ ,  $V_{GE}=15\text{V}$ ,  $I_C=15\text{A}$

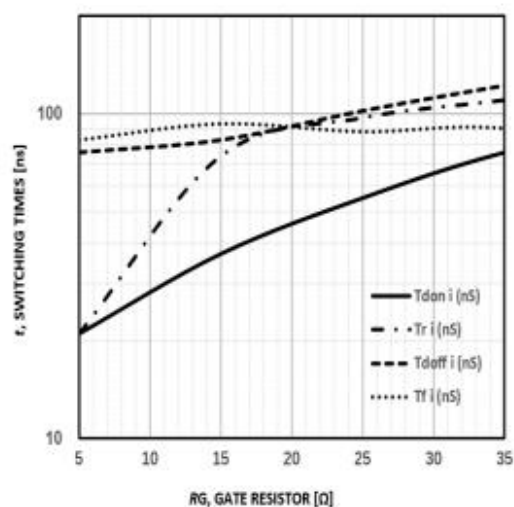


Figure10: Typical switching time VS.  $R_g$ ,  $T_C=25^{\circ}\text{C}$ ,  
 $V_{CE}=600\text{V}$ ,  $V_{GE}=15\text{V}$ ,  $I_C=15\text{A}$

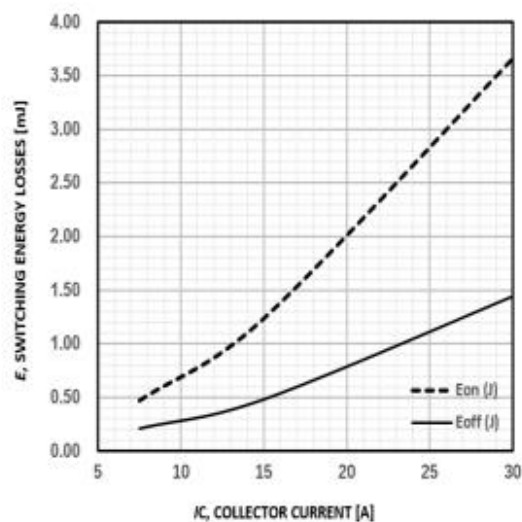


Figure11: Typical energy loss VS.  $I_C$ ,  $T_C=25^{\circ}\text{C}$ ,  
 $V_{CE}=600\text{V}$ ,  $V_{GE}=15\text{V}$ ,  $R_g=15\Omega$

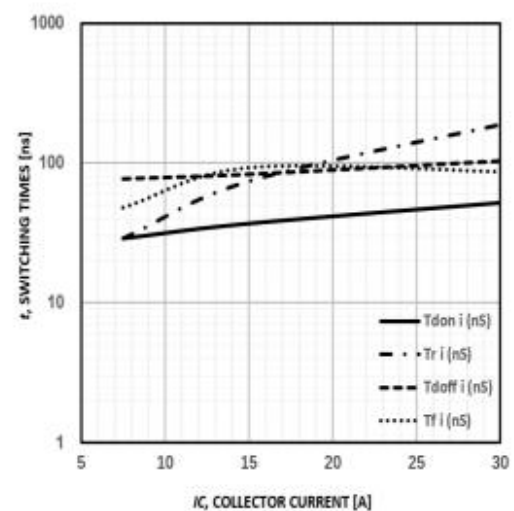


Figure12: Typical switching time VS.  $I_C$ ,  $T_C=25^{\circ}\text{C}$ ,  
 $V_{CE}=600\text{V}$ ,  $V_{GE}=15\text{V}$ ,  $R_g=15\Omega$

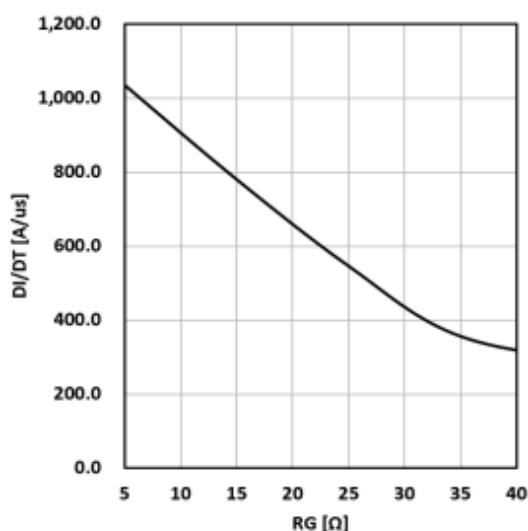


Figure 13. Typical diode di/dt vs rg Tc=25℃  
VCE=600V VGE=15V IF=15A

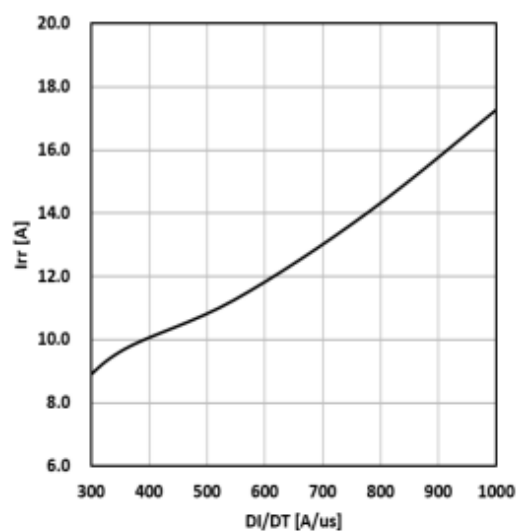


Figure 14. Typical diode irr vs di/dt Tc=25℃  
VCE=600V VGE=15V IF=15A

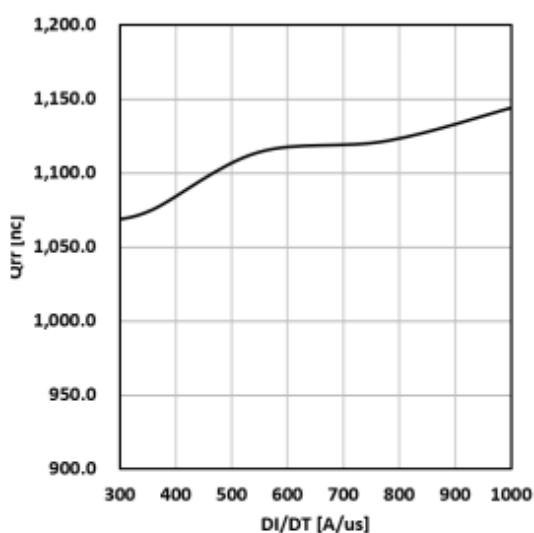


Figure 15. Typical diode Qrr vs di/dt Tc=25℃  
VCE=600V VGE=15V IF=15A

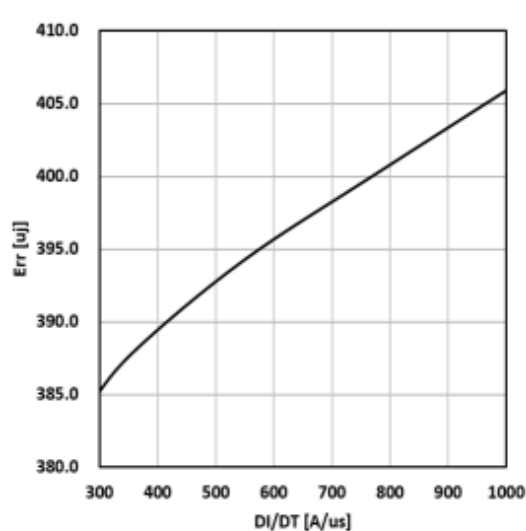


Figure 16. Typical diode Err vs di/dt Tc=25℃  
VCC=600V VGE=15V IF=15A

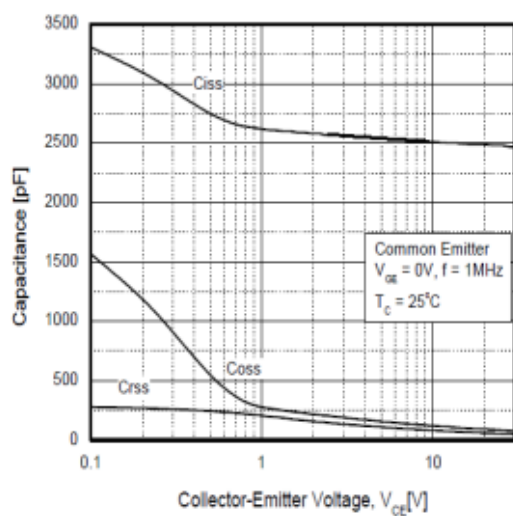


Figure17: Typical capacitance VS. VCE,  
VGE=0V, f=1MHz

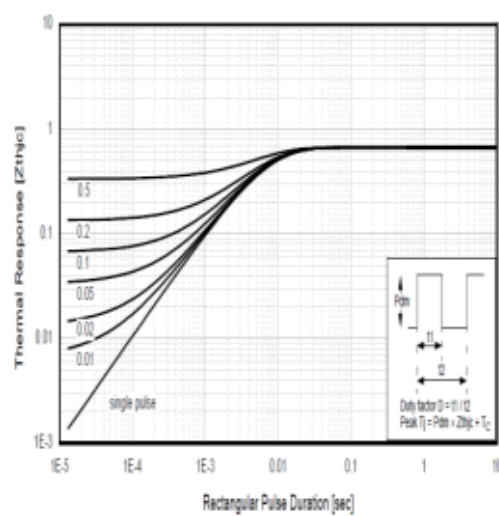
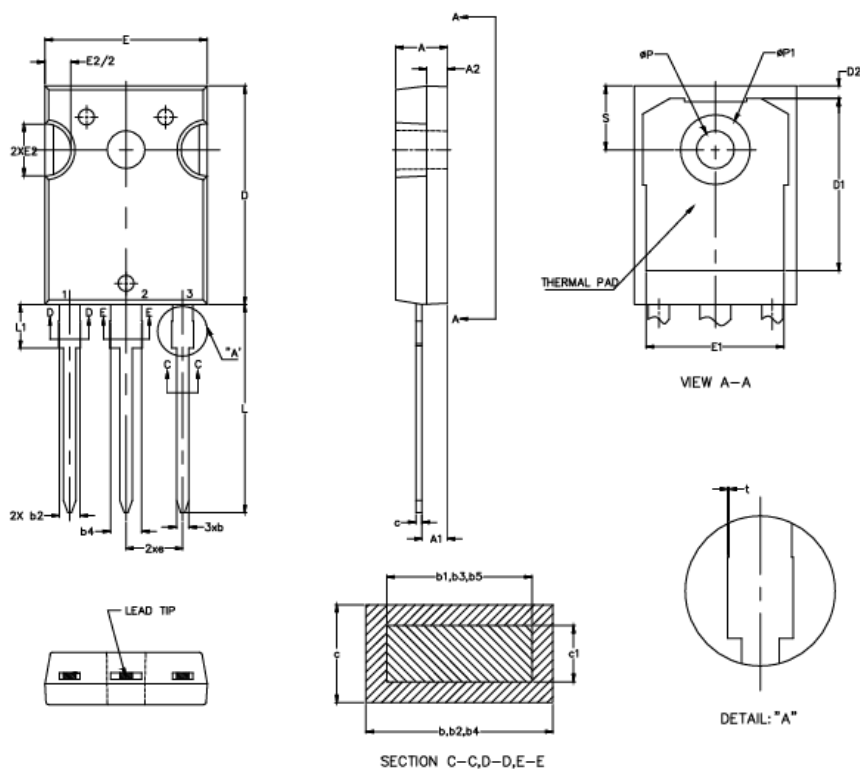


Figure18. normalized transient thermal impedance,  
junction-to-case



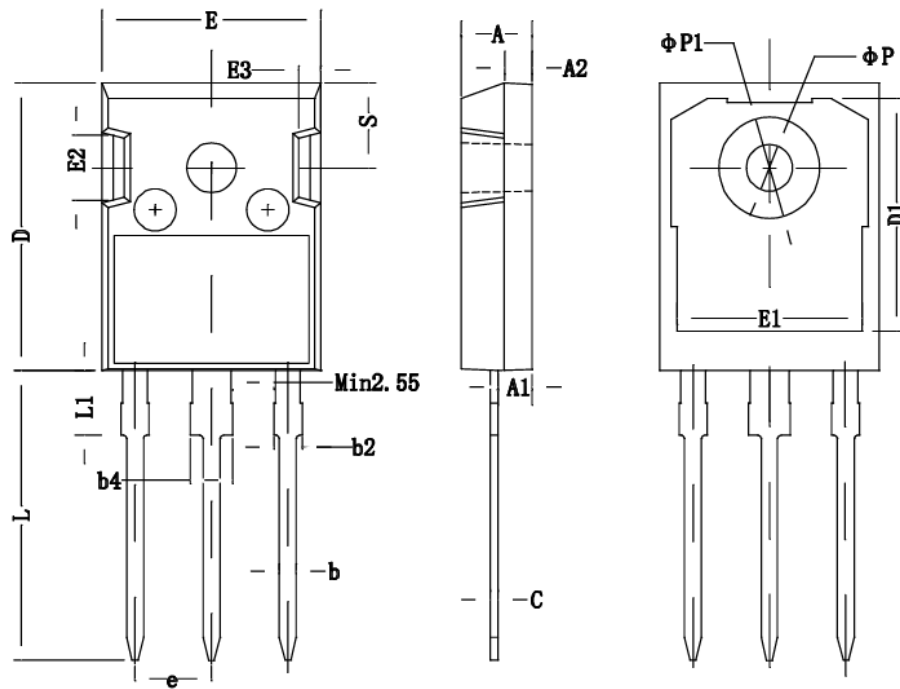
## TO247(圆弧) PACKAGE OUTLINE



DIMENSIONS				
	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A	4.90	5.10	0.193	0.201
A1	2.31	2.51	0.091	0.099
A2	1.90	2.10	0.075	0.083
b	1.16	1.26	0.046	0.050
b1	1.15	1.22	0.045	0.048
b2	1.96	2.06	0.077	0.081
b3	1.95	2.02	0.077	0.080
b4	2.96	3.06	0.117	0.120
b5	2.95	3.02	0.116	0.119
c	0.59	0.66	0.023	0.026
c1	0.58	0.62	0.023	0.024
D	20.90	21.10	0.823	0.831
D1	16.25	16.85	0.640	0.663
D2	1.05	1.35	0.041	0.053
E	15.75	15.90	0.620	0.626
E1	13.26	—	0.552	—
E2	4.90	5.10	0.193	0.201
e	5.44BSC		0.214BSC	
L	19.80	20.10	0.780	0.791
L1	—	4.30	—	0.169
ØP	3.50	3.70	0.138	0.146
ØP1	—	7.40	—	0.291
S	6.05	6.25	0.238	0.246
t	0.00	0.15	0.000	0.006



## TO247(直角) PACKAGE OUTLINE



Symbol	mm		
	Min	Non	Max
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.80	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.82	19.92	20.22
L1	-	-	4.30
$\phi P$	3.40	3.60	3.80
$\phi P1$	-	-	7.30
S	6.15BSC		

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